38 V, 3 A synchronous step-down converter with 17 μA quiescent current

Features

- 3.5 V to 38 V operating input voltage
- Output voltage from 0.85 V to $V_{IN}$
- 3.3 V and 5 V fixed output voltage versions
- 3 A DC output current
- 17 μA operating quiescent current
- Internal compensation network
- Two different versions: LCM for high efficiency at light loads and LNM for noise sensitive applications
- 2 μA shutdown current
- Internal soft-start
- Enable
- Overvoltage protection
- Output voltage sequencing
- Thermal protection
- 200 kHz to 2.3 MHz programmable switching frequency. Stable with low ESR capacitor
- Optional spread spectrum for improved EMC
- Power Good
- Synchronization to external clock for LNM devices
- QFN16 package

Applications

- Designed for 24 V buses industrial power systems
- 24 V battery powered equipment
- Decentralized intelligent nodes
- Sensors and always-on applications
- Low noise applications

Description

The L6983 is an easy to use synchronous monolithic step-down regulator capable of delivering up to 3 A DC to the load. The wide input voltage range makes the device suitable for a broad range of applications. The L6983 is based on a peak current mode architecture and is packaged in a QFN16 3x3 with internal compensation thus minimizing design complexity and size.

The L6983 is available both in low consumption mode (LCM) and low noise mode (LNM) versions. LCM maximizes the efficiency at light-load with controlled output voltage ripple so the device is suitable for battery-powered applications. LNM makes the switching frequency constant and minimizes the output voltage ripple for light load operations, meeting the specification for low noise sensitive applications. The L6983 allows the switching frequency to be selected in the 200 kHz - 2.3 MHz range with optional spread spectrum for improved EMC.
The EN pin provides enable/disable function. The typical shutdown current is 2 µA when disabled. As soon as the EN pin is pulled up, the device is enabled and the internal 1.3 ms soft-start takes place. The L6983 features Power Good open collector that monitors the FB voltage. Pulse-by-pulse current sensing on both power elements implements an effective constant current protection and thermal shutdown prevents thermal run-away.
Figure 1. Block diagram
2 Pin configuration

Figure 2. Pin connection (top through view)

Table 1. Pin description

<table>
<thead>
<tr>
<th>Pin</th>
<th>Symbol</th>
<th>Function</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>VIN</td>
<td>DC input voltage.</td>
</tr>
<tr>
<td>2</td>
<td>VINLDO</td>
<td>DC input voltage connected to the supply rail with a simple RC filter.</td>
</tr>
<tr>
<td>3</td>
<td>AGND</td>
<td>Analog ground.</td>
</tr>
<tr>
<td>4</td>
<td>EN / CLKIN</td>
<td>Enable pin with internal voltage divider. Pull-down/up to disable/enable the device. In LNM versions, this pin is also used to provide an external clock signal, which synchronizes the device.</td>
</tr>
<tr>
<td>5</td>
<td>PGOOD</td>
<td>The PGOOD open collector output is driven to low impedance when the output voltage is out of regulation and released once the output voltage becomes valid.</td>
</tr>
<tr>
<td>6</td>
<td>VBIAS</td>
<td>Typically connected to the regulated output voltage, an external voltage source can be used to supply part of the analog circuitry to reduce current consumption at light load. Connect it to AGND if not used.</td>
</tr>
<tr>
<td>7</td>
<td>FB/VOUT</td>
<td>This pin operates as VOUT or FB according to the selected part number. In fixed output voltage versions, VOUT is the output voltage sensing with selected internal voltage divider. In adjustable versions, FB is output voltage sensing with external voltage divider.</td>
</tr>
<tr>
<td>8</td>
<td>FSW</td>
<td>Connect an external resistor to program the oscillator frequency and enable the optional dithering.</td>
</tr>
<tr>
<td>9</td>
<td>VCC</td>
<td>This pin supplies the embedded analog circuitry. Connect a ceramic capacitor (≥ 1 µF) to filter internal voltage reference.</td>
</tr>
<tr>
<td>10</td>
<td>AGND</td>
<td>Analog ground.</td>
</tr>
<tr>
<td>11</td>
<td>BOOT</td>
<td>Connect an external capacitor (100 nF typ.) between BOOT and SW pins. The gate charge required to drive the internal NMOS is refreshed during the low-side switch conduction time.</td>
</tr>
<tr>
<td>Pin</td>
<td>Symbol</td>
<td>Function</td>
</tr>
<tr>
<td>-----</td>
<td>--------</td>
<td>---------------------------------</td>
</tr>
<tr>
<td>12</td>
<td>VIN</td>
<td>DC input voltage.</td>
</tr>
<tr>
<td>13</td>
<td>PGND</td>
<td>Power ground.</td>
</tr>
<tr>
<td>14</td>
<td>SW</td>
<td>Switching node.</td>
</tr>
<tr>
<td>15</td>
<td>SW</td>
<td>Switching node.</td>
</tr>
<tr>
<td>16</td>
<td>PGND</td>
<td>Power ground.</td>
</tr>
<tr>
<td>-</td>
<td>Exposed PAD</td>
<td>Exposed pad must be connected to AGND and PGND.</td>
</tr>
</tbody>
</table>
3 Typical application circuit

Figure 3. Basic application (adjustable version)

Table 2. Typical application component

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Value</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>C\text{IN}</td>
<td>10 \mu F</td>
<td>Input capacitor</td>
</tr>
<tr>
<td>R\text{FILT}</td>
<td>0.1 k\Omega</td>
<td>VINLDO filter resistor</td>
</tr>
<tr>
<td>C\text{FILT}</td>
<td>1 \mu F</td>
<td>VINLDO filter capacitor</td>
</tr>
<tr>
<td>C\text{VCC}</td>
<td>1 \mu F</td>
<td>VCC bypass capacitor</td>
</tr>
<tr>
<td>C\text{BOOT}</td>
<td>100 nF</td>
<td>Bootstrap capacitor</td>
</tr>
<tr>
<td>C\text{OUT}</td>
<td>40 \mu F</td>
<td>Output capacitor</td>
</tr>
<tr>
<td>R\text{FBH}</td>
<td>400 k\Omega</td>
<td>VOUT divider upper resistor</td>
</tr>
<tr>
<td>R\text{FBL}</td>
<td>82 k\Omega</td>
<td>VOUT divider lower resistor</td>
</tr>
<tr>
<td>L</td>
<td>4.7 \mu H (F\text{SW} = 1 MHz)</td>
<td>Output inductor</td>
</tr>
<tr>
<td>R\text{PGOOD}</td>
<td>1 M\Omega</td>
<td>PGOOD resistor</td>
</tr>
<tr>
<td>R\text{FSW}</td>
<td>10 k\Omega</td>
<td>FSW setting resistor</td>
</tr>
</tbody>
</table>
4 Absolute maximum ratings

Stressing the device above the rating listed in Section 4 Absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

Table 3. Absolute maximum ratings

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Min.</th>
<th>Max.</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>VIN</td>
<td>Maximum pin voltage</td>
<td>-0.3</td>
<td>42</td>
<td>V</td>
</tr>
<tr>
<td>AGND</td>
<td>Maximum pin voltage</td>
<td>0</td>
<td>0</td>
<td>V</td>
</tr>
<tr>
<td>PGND</td>
<td>Maximum pin voltage</td>
<td>-0.3</td>
<td>0.3</td>
<td>V</td>
</tr>
<tr>
<td>BOOT</td>
<td>Maximum pin voltage</td>
<td>SW -0.3</td>
<td>SW + 4</td>
<td>V</td>
</tr>
<tr>
<td>VCC</td>
<td>Maximum pin voltage</td>
<td>-0.3</td>
<td>Min. (VIN + 0.3 V; 4 V)</td>
<td>V</td>
</tr>
<tr>
<td>VOUT/FB</td>
<td>Maximum pin voltage</td>
<td>-0.3</td>
<td>8</td>
<td>V</td>
</tr>
<tr>
<td>FSW</td>
<td>Maximum pin voltage</td>
<td>-0.3</td>
<td>VCC + 0.3</td>
<td>V</td>
</tr>
<tr>
<td>VBIAS</td>
<td>Maximum pin voltage</td>
<td>-0.3</td>
<td>VIN + 0.3</td>
<td>V</td>
</tr>
<tr>
<td>EN</td>
<td>Maximum pin voltage</td>
<td>-0.3</td>
<td>VIN + 0.3</td>
<td>V</td>
</tr>
<tr>
<td>PGOOD</td>
<td>Maximum pin voltage</td>
<td>-0.3</td>
<td>VIN + 0.3</td>
<td>V</td>
</tr>
<tr>
<td>SW</td>
<td>Maximum pin voltage</td>
<td>-0.85</td>
<td>VIN + 0.3</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>-3.8 for 0.5 ns (1)</td>
<td>V</td>
</tr>
<tr>
<td>IHS, ILS</td>
<td>High-side / Low-side RMS switch current</td>
<td></td>
<td>3</td>
<td>A</td>
</tr>
<tr>
<td>T J</td>
<td>Operating temperature range</td>
<td>-40</td>
<td>150</td>
<td>°C</td>
</tr>
<tr>
<td>TSTG</td>
<td>Storage temperature range</td>
<td>-65</td>
<td>150</td>
<td>°C</td>
</tr>
<tr>
<td>TLEAD</td>
<td>Lead temperature (soldering 10 sec.)</td>
<td></td>
<td>260</td>
<td>°C</td>
</tr>
</tbody>
</table>

1. Negative peak voltage during switching activities caused by parasitic layout elements.

4.1 ESD protection

Table 4. ESD performance

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Test conditions</th>
<th>Value</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>ESD</td>
<td>ESD protection voltage</td>
<td>HBM</td>
<td>2</td>
<td>kV</td>
</tr>
<tr>
<td></td>
<td></td>
<td>CDM</td>
<td>500</td>
<td>V</td>
</tr>
</tbody>
</table>

4.2 Thermal characteristics

Table 5. Thermal data

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Package</th>
<th>Value</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>Rth_JA</td>
<td>Thermal resistance junction ambient (device soldered on the STMicroelectronics demonstration board, please refer to Section 9 Application board)</td>
<td>QFN16</td>
<td>30</td>
<td>°C/W</td>
</tr>
</tbody>
</table>
5 Electrical characteristics

$T_J = 25 \, ^\circ C, \, V_{IN} = 24 \, V$ unless otherwise specified.

### Table 6. Electrical characteristics

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Test conditions</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>(V_{IN})</td>
<td>Operating input voltage range</td>
<td></td>
<td>3.5</td>
<td>38</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>(V_{IN_H})</td>
<td>(V_{CC}) rising threshold</td>
<td></td>
<td>2.3</td>
<td>3.3</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>(V_{IN_L})</td>
<td>(V_{CC\ UVLO}) falling threshold</td>
<td></td>
<td>2.15</td>
<td>3.15</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>(I_{PK}^{(1)})</td>
<td>Peak current limit</td>
<td>No slope contribution</td>
<td>4.1</td>
<td>4.6</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Full slope contribution</td>
<td>3.1</td>
<td>3.6</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td>(I_{VY})</td>
<td>Valley current limit</td>
<td></td>
<td>3.3</td>
<td>3.9</td>
<td>4.5</td>
<td>A</td>
</tr>
<tr>
<td>(I_{SKIP}^{(1)(2)})</td>
<td>Skip current limit</td>
<td></td>
<td>0.6</td>
<td></td>
<td></td>
<td>A</td>
</tr>
<tr>
<td>(I_{VY_SINK}^{(1)})</td>
<td>Reverse current limit</td>
<td>LNM or VOUT overvoltage</td>
<td>1.25</td>
<td>1.5</td>
<td>1.75</td>
<td>A</td>
</tr>
<tr>
<td>(R_{DSON_HS})</td>
<td>High-side (R_{DSON})</td>
<td></td>
<td>0.130</td>
<td></td>
<td></td>
<td>Ω</td>
</tr>
<tr>
<td>(R_{DSON_LS})</td>
<td>Low-side (R_{DSON})</td>
<td></td>
<td>0.085</td>
<td></td>
<td></td>
<td>Ω</td>
</tr>
<tr>
<td>(T_{OFF_MIN})</td>
<td>Minimum off-time</td>
<td></td>
<td>200</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>(T_{ON_MIN})</td>
<td>Minimum on-time</td>
<td></td>
<td>75</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>(V_{WAKE_UP})</td>
<td>Wake-up threshold</td>
<td>Rising</td>
<td>0.7</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Falling</td>
<td>0.2</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>(V_{EN})</td>
<td>Enable threshold</td>
<td>Rising</td>
<td>1.08</td>
<td>1.2</td>
<td>1.32</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Hysteresis</td>
<td>0.2</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>(V_{CC})</td>
<td>LDO output voltage</td>
<td></td>
<td>3.0</td>
<td>3.3</td>
<td>3.6</td>
<td>V</td>
</tr>
<tr>
<td>(I_{SHTDWN})</td>
<td>Shutdown current from (V_{IN})</td>
<td>(VEN = GND)</td>
<td>2</td>
<td>3</td>
<td></td>
<td>μA</td>
</tr>
<tr>
<td>(I_{Q_VIN})</td>
<td>Quiescent current from (V_{IN})</td>
<td>(VBIAS = GND)</td>
<td>20</td>
<td>35</td>
<td>60</td>
<td>μA</td>
</tr>
<tr>
<td></td>
<td></td>
<td>(VBIAS = 5 , V)</td>
<td>1</td>
<td>3.5</td>
<td>6</td>
<td>μA</td>
</tr>
<tr>
<td>(I_{Q_VBIAS})</td>
<td>Quiescent current from (V_{BIAS})</td>
<td>(VBIAS = 5 , V)</td>
<td>20</td>
<td>35</td>
<td>60</td>
<td>μA</td>
</tr>
<tr>
<td>(I_{Q_VIN})</td>
<td>Quiescent current from (V_{IN})</td>
<td>(VBIAS = GND)</td>
<td>1.6</td>
<td>2.3</td>
<td>3</td>
<td>mA</td>
</tr>
<tr>
<td></td>
<td></td>
<td>(VBIAS = 5 , V)</td>
<td>300</td>
<td>550</td>
<td>800</td>
<td>μA</td>
</tr>
<tr>
<td>(I_{Q_VBIAS})</td>
<td>Quiescent current from (V_{BIAS})</td>
<td>(VBIAS = 5 , V)</td>
<td>1.3</td>
<td>1.8</td>
<td>2.3</td>
<td>mA</td>
</tr>
</tbody>
</table>

### Soft-start
<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Test conditions</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>TSS</td>
<td>Internal soft-start</td>
<td></td>
<td>1</td>
<td>1.3</td>
<td>1.6</td>
<td>ms</td>
</tr>
</tbody>
</table>

#### Error amplifier

<table>
<thead>
<tr>
<th>VFB</th>
<th>Voltage feedback</th>
<th>Adjustable version</th>
<th>T_J = 25 °C</th>
<th>0.845</th>
<th>0.85</th>
<th>0.855</th>
<th>V</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>Adjustable version</td>
<td>T_J = -40 °C ≤ T_J ≤ 125 °C</td>
<td>0.842</td>
<td>0.85</td>
<td>0.858</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Fixed 3.3 V version</td>
<td>T_J = 25 °C</td>
<td>3.27</td>
<td>3.3</td>
<td>3.33</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Fixed 3.3 V version</td>
<td>T_J = -40 °C ≤ T_J ≤ 125 °C</td>
<td>3.284</td>
<td>3.3</td>
<td>3.346</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Fixed 5.0 V version</td>
<td>T_J = 25 °C</td>
<td>4.955</td>
<td>5.0</td>
<td>5.045</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Fixed 5.0 V version</td>
<td>T_J = -40 °C ≤ T_J ≤ 125 °C</td>
<td>4.93</td>
<td>5</td>
<td>5.07</td>
<td>V</td>
</tr>
</tbody>
</table>

#### Overvoltage protection

<table>
<thead>
<tr>
<th>V_OVP</th>
<th>Overvoltage trip (VOVP/VREF)</th>
<th>115</th>
<th>120</th>
<th>125</th>
<th>%</th>
</tr>
</thead>
<tbody>
<tr>
<td>V_OVP_HYST</td>
<td>Overvoltage hysteresis</td>
<td>1</td>
<td>2</td>
<td>6</td>
<td>%</td>
</tr>
</tbody>
</table>

#### Synchronization (LNM versions only)

<table>
<thead>
<tr>
<th>f_CLKIN (3)</th>
<th>Synchronization range</th>
<th>200</th>
<th>2200</th>
<th>kHz</th>
</tr>
</thead>
<tbody>
<tr>
<td>V_CLKIN_TH (3)</td>
<td>Amplitude of synchronization clock</td>
<td>2.3</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>V_CLKIN_T (3)</td>
<td>Synchronization pulse ON and OFF time 2.3 V ≤ V_CLKIN_TH ≤ 2.5 V</td>
<td>V_CLKIN_TH = 2.3 V</td>
<td>60</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>Synchronization pulse ON and OFF time V_CLKIN_TH &gt; 2.5 V</td>
<td>V_CLKIN_TH = 2.3 V</td>
<td>20</td>
<td>ns</td>
</tr>
</tbody>
</table>

#### Power Good

<table>
<thead>
<tr>
<th>V_THR</th>
<th>PGOOD threshold</th>
<th>Adjustable output version</th>
<th>T_J = -40 °C ≤ T_J ≤ 125 °C</th>
<th>87</th>
<th>90</th>
<th>93</th>
<th>%</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>Fixed 3.3 output version</td>
<td>T_J = -40 °C ≤ T_J ≤ 125 °C</td>
<td>87</td>
<td>90</td>
<td>93</td>
<td>%</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Fixed 5.0 output version</td>
<td>T_J = -40 °C ≤ T_J ≤ 125 °C</td>
<td>87</td>
<td>90</td>
<td>93</td>
<td>%</td>
</tr>
<tr>
<td>V_THR_HYST (4)</td>
<td>PGOOD hysteresis</td>
<td></td>
<td></td>
<td>3</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>V_PGOOD</td>
<td>PGOOD open collector output</td>
<td>VIN &gt; VIN_H AND VFB &lt; VTH</td>
<td>4 mA sinking load</td>
<td>0.4</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>2 &lt; VIN &lt; VIN_H</td>
<td>4 mA sinking load</td>
<td>0.8</td>
<td>V</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

(3) Unless otherwise specified, the nominal supply voltage is Vss = ±5 V.
(4) For LNM versions only.
<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Test conditions</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>$T_{\text{SHDWN}}$</td>
<td>Thermal shutdown temperature</td>
<td>165</td>
<td>°C</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$T_{\text{HYS}}$</td>
<td>Thermal shutdown hysteresis</td>
<td>30</td>
<td>°C</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

1. Parameter tested in the static condition during testing phase. The parameter value may change over a dynamic application condition.
2. LCM version.
3. LNM version.
4. Specifications in the -40 to 125 °C temperature range are assured by characterization and statistical correlation.
5. Not tested in production.

### 5.1 Frequency selection table

Specification referred to -40 ≤ $T_J$ ≤ 125 °C and $V_{\text{IN}}$ = 24 V, assured by testing at $T_J$ = 25 °C, design, characterization and statistical correlation.

#### Table 7. FSW selection

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Option</th>
<th>RVCC (kΩ)</th>
<th>RGND (kΩ)</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>FSW</td>
<td>Dithering (5% FSW typ.)</td>
<td>1.8</td>
<td>N.C.</td>
<td>200</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>0</td>
<td>N.C.</td>
<td>400</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>3.3</td>
<td>N.C.</td>
<td>500</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>5.6</td>
<td>N.C.</td>
<td>700</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>10</td>
<td>N.C.</td>
<td>1000</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>18</td>
<td>N.C.</td>
<td>1500</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>33</td>
<td>N.C.</td>
<td>2000</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>56</td>
<td>N.C.</td>
<td>2300</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>No dithering</td>
<td>N.C.</td>
<td>1.8</td>
<td>200</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>N.C.</td>
<td>0</td>
<td>360</td>
<td>440</td>
<td>kHz</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>N.C.</td>
<td>3.3</td>
<td>500</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>N.C.</td>
<td>5.6</td>
<td>630</td>
<td>770</td>
<td>kHz</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>N.C.</td>
<td>10</td>
<td>900</td>
<td>1100</td>
<td>kHz</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>N.C.</td>
<td>18</td>
<td>1500</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>N.C.</td>
<td>33</td>
<td>2000</td>
<td>kHz</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>N.C.</td>
<td>56</td>
<td>2000</td>
<td>2600</td>
<td>kHz</td>
<td></td>
</tr>
</tbody>
</table>
Functional description

The L6983 device is based on a "peak current mode" architecture with constant frequency control. Therefore, the intersection between the error amplifier output and the sensed inductor current generates the PWM control signal to drive the power switch.

The device features LNM (low noise mode) that is forced PWM control, or LCM (low consumption mode) to increase the efficiency at light-load on the selected part number.

The main internal blocks shown in the block diagram in Figure 1. Block diagram and Figure 2. Pin connection (top through view) are:

- Embedded power elements
- A fully integrated adjustable oscillator which is able to set eight different switching frequencies from 200 to 2300 kHz
- The ramp for the slope compensation avoiding subharmonic instability
- A transconductance error amplifier with integrated compensation network
- The high-side current sense amplifier to sense the inductor current
- A “Pulse Width Modulator” (PWM) comparator and the driving circuitry of the embedded power elements
- The soft-start block ramps up the reference voltage on error amplifier thus decreasing the inrush current at power-up. The EN pin inhibits the device when driven low
- The EN/CLK pin section, which, for LNM versions, allows synchronizing the device to an external clock generator
- The pulse-by-pulse high-side / low-side switch current sensing to implement the constant current protection
- A circuit to implement the thermal protection function
- The OVP circuitry to discharge the output capacitor in case of overvoltage event
- The switchover capability of the internal regulator to supply a portion of the quiescent current when the VBIAS pin is connected to an external output voltage
- Enable/ disable dithering operation

6.1 Enable

The EN pin is a digital input that turns the device on or off.

In order to maximize both the EN threshold accuracy and the current consumption, the device implements two different thresholds:

1. The wake-up threshold, $V_{WAKE\_UP} = 0.5$ V (see Table 6. Electrical characteristics)
2. The start-up threshold, $V_{EN} = 1.2$ V (see Table 6. Electrical characteristics)

The following picture shows the device behavior.
Figure 4. Power-up/down behavior

When the voltage applied on the EN pin rises over \( V_{\text{WAKEUP, RISING}} \), the device powers up the internal circuit thus increasing the current consumption.

As soon as the voltage rises over the \( V_{\text{EN, RISING}} \), the device starts the switching activities as described on Section 6.2 Soft-start.

Once the voltage becomes lower than \( V_{\text{EN, FALLING}} \), the device interrupts the switching activities.

As soon as the voltage becomes lower than \( V_{\text{WAKEUP,FALLING}} \), the device powers down the internal circuit reducing the current consumption.

The pin is VIN compatible.

Please refer to Table 6. Electrical characteristics for the reported thresholds.

6.2 Soft-start

The soft-start (SS) limits the inrush current surge and makes the output voltage increase monotonically.

The device implements the soft-start phase ramping the internal reference with very small steps. Once the SS ends the error amplifier reference is switched to the internal value of 0.85 V coming directly from the band gap cell.
During the normal operation, a new soft-start cycle takes place in case of:
1. Thermal shutdown event
2. UVLO event
3. EN pin rising over VEN threshold. Please refer to Table 6. Electrical characteristics

6.3 Undervoltage lockout

The device implements the undervoltage lockout (UVLO) continuously sensing the voltage on the VCC pin, if the UVLO lasts more than 10 μs, the internal logic resets the device by turning off both LS and HS. After the reset, if the EN pin is still high, the device repeats the soft-start procedure.
6.4 Light-load operation

The L6983 implements two different light load strategies:

1. Low consumption mode (LCM)
2. Low noise mode (LNM)

Please refer to Table 12. Order codes to select the part number with the preferred light load strategy.

6.4.1 Low consumption mode (LCM)

The LCM maximizes the efficiency at light load.

When the switch peak current request is lower than the $I_{\text{SKIP}}$ threshold (see Table 6. Electrical characteristics), the device regulates $V_{\text{OUT}}$ by the skip threshold. The minimum voltage is given by:

$$ V_{\text{OUT, LCM}} = V_{FB, LCM} \cdot \frac{R_{PH} + R_{PL}}{R_{PL}} $$

Where $V_{FB, LCM}$ is 1.8\% (typ.) higher than $V_{FB}$.

The device interrupts the switching activities when two conditions happen together:

1. The peak inductor current required is lower than $I_{\text{SKIP}}$
2. The voltage on the FB pin is higher than $V_{FB, LCM}$

A new switching cycle takes place once the voltage on the FB pin becomes lower than $V_{FB, LCM}$.

The HS switch is kept on until the inductor current reaches $I_{\text{SKIP}}$.

Once the current on the HS reaches the defined value, the device turns the HS off and turns the LS on. The LS is kept enabled until one of the following conditions occurs:

1) The inductor current sensed by the LS becomes equal to zero
2) The switching period ends

If, at the end of the switching cycle, the voltage on the FB pin rises over the $V_{FB, LCM}$ threshold, the LS is kept enabled until the inductor current becomes equal to zero. Otherwise, the device turns on again the HS and starts a new switching pulse.

During the burst pulse, if the energy transferred to $C_{\text{OUT}}$ increases the $V_{FB}$ level over the threshold defined on Eq. (1), the device interrupts the switching activities. The new cycle takes place only when $V_{FB}$ becomes lower than the defined threshold. Otherwise, as soon as the LS is turned off the HS is turned on.

Given the energy stored in the inductor during a burst, the voltage ripple depends on the capacitor value:

$$ \frac{\Delta Q_{IL}}{C_{OUT}} = \frac{T_{\text{BURST}}}{C_{OUT}} \int_{t_0}^{t_{\text{BURST}}} I_{L}(t) \, dt $$

$$ V_{\text{OUT RIPPLE}} = \frac{\Delta Q_{IL}}{C_{OUT}} $$
Figure 8. LCM operation with $I_{\text{SKIP}} = 600$ mA typ. at zero load. $L = 15$ $\mu$H; $C_{\text{OUT}} = 40$ $\mu$F

<table>
<thead>
<tr>
<th>File</th>
<th>Serial</th>
<th>Host/Tag</th>
<th>Tag</th>
<th>Device</th>
<th>Connect</th>
<th>Measure</th>
<th>Source</th>
<th>All/Scope</th>
<th>Analysis</th>
<th>Image</th>
<th>Info</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

Figure 9. LCM operation over loading condition (part 1-pulse skipping)
Figure 10. LCM operation over loading condition (part 2-pulse skipping)

Figure 11. LCM operation over loading condition (part 3-pulse skipping)
Figure 12. LCM operation over loading condition (part 4-CCM)
6.4.2 Low noise mode (LNM)

The low noise mode implements a forced PWM operation over the different loading conditions. The LNM features a constant switching frequency to minimize the noise in the final application and a constant voltage ripple at fixed VIN.

The regulator in steady loading condition operates in continuous conduction mode (CCM) over the different loading conditions.

The triangular shape current ripple (with zero average value) flowing into the output capacitor gives the output voltage ripple, that depends on the capacitor value and the equivalent resistive component (ESR). Consequently, the output capacitor has to be selected in order to have a voltage ripple compliant with the application requirements.

\[
V_{\text{OUT RIPPLE}} = ESR \cdot \Delta I_{\text{MAX}} + \frac{\Delta I_{\text{MAX}}}{B \cdot C_{\text{OUT}} \cdot f_{\text{SW}}} \tag{3}
\]

Usually the resistive component of the ripple can be neglected if the selected output capacitor is a multi-layer ceramic capacitor (MLCC).
6.4.3 Efficiency for low consumption mode and low noise mode part number

Figure 14. Light-load efficiency for low consumption mode and low noise mode - linear scale, and Figure 15. Light-load efficiency for low consumption mode and low noise mode - log scale report the efficiency measurements to highlight the gap at the light-load between LNM and LCM part numbers. The graph reports also exactly the same efficiency at the medium / high load.

Figure 14. Light-load efficiency for low consumption mode and low noise mode - linear scale

\[ V_{IN} = 24 \, V; \, V_{OUT} = 5 \, V; \, F_{SW} = 0.4 \, MHz \]

Figure 15. Light-load efficiency for low consumption mode and low noise mode - log scale

\[ V_{IN} = 24 \, V; \, V_{OUT} = 5 \, V; \, F_{SW} = 0.4 \, MHz \]
6.4.4 Load regulation for low consumption mode and Low noise mode part number

Figure 16. Load regulation for LCM and LNM. $V_{IN} = 24\, V$; $V_{OUT} = 5\, V$; $F_{SW} = 400\, kHz$ - linear scale and

Figure 17. Load regulation for low noise mode. $V_{IN} = 24\, V$; $V_{OUT} = 5\, V$; $F_{SW} = 400\, kHz$ - log scale report the load regulation to highlight the gap, given by the different regulation strategy, at the light-load between LNM and LCM part numbers. When the required $I_{OUT}$ is higher than the threshold defined on the Section 6.4.1 Low consumption mode (LCM) the behavior of the different part number is exactly the same.

Figure 16. Load regulation for LCM and LNM. $V_{IN} = 24\, V$; $V_{OUT} = 5\, V$; $F_{SW} = 400\, kHz$ - linear scale

![Graph 1](image1)

Figure 17. Load regulation for low noise mode. $V_{IN} = 24\, V$; $V_{OUT} = 5\, V$; $F_{SW} = 400\, kHz$ - log scale

![Graph 2](image2)
6.5 Switch-over feature

The switch-over maximizes the efficiency at light load that is crucial for low consumption application.

**Figure 18. Switch-over**

In order to minimize the regulator quiescent current sink from the input voltage, the VBIAS pin can be connected to an external voltage source in the range of \(3.0 \, \text{V} < \text{VBIAS} < \text{VIN}\).

In case the VBIAS pin is connected to the regulated output voltage (VOUT), the total current drawn from the input voltage is given by the following equation:

\[
\frac{I_{Q\text{VIN}}}{\text{VIN}} = \frac{1}{\eta_{L6983}} \cdot \frac{V_{\text{BIAS}}}{V_{\text{IN}}} \cdot I_{Q\text{OPVBIAS}}
\]

6.6 Spread spectrum

The spread spectrum is selectable by connecting the RFSW resistor to VCC (please refer to Table 7. FSW selection). The internal dithering circuit changes the switching frequency in a range of \(\pm 5\%\).

\[
\Delta F_{SW} = 5\% \cdot F_{SW}
\]

The device updates the frequency every clock period by fixed steps:

- Ramps up in 63 steps from minimum to maximum FSW
- Ramps down in 63 steps from maximum to minimum FSW

The modulation shape is almost triangular with a frequency of:

\[
F_{\text{Dithering}} = \frac{F_{SW}}{126}
\]

6.7 Overvoltage protection

The overvoltage protection monitors the FB pin and enables the low-side MOSFET to discharge the output capacitor if the output voltage is 20\% (typ.) over the nominal value.

This is a second level protection and it should never be triggered in normal operating conditions if the system is properly dimensioned. In other words, the selection of the external power components and the dynamic performance determined by the compensation network should guarantee an output voltage regulation within the overvoltage threshold even during the worst-case scenario in terms of load transitions.

The protection is reliable and able to operate even during normal load transitions for a system whose dynamic performance is not in line with the load dynamic request. Consequently, the output voltage regulation would be affected.

The L6983 device implements a 1.5 A \((I_{VY\text{-SINK}}\) refer to Table 6. Electrical characteristics) negative current limitation to limit the maximum reversed switch current during the overvoltage operation.
6.8 Overcurrent protection

The current protection circuitry features a constant current protection, so the device limits the maximum peak current (please refer to Table 6. Electrical characteristics) in overcurrent condition.

The L6983 device implements a pulse-by-pulse current sensing on both power elements (high-side and low-side switches) for effective current protection over the duty cycle range. The high-side current sensing is called “peak” the low-side sensing “valley”.

The internal noise generated during the switching activity makes the current sensing circuitry ineffective for a minimum conduction time of the power element. This time is called “masking time” because the information from the analog circuitry is masked by the logic to prevent an erroneous detection of the overcurrent event. Therefore, the peak current protection is disabled for a masking time after the high-side switch is turned on. The masking time for the valley sensing is activated after the low-side switch is turned on. In other words, the peak current protection can be ineffective at extremely low duty cycles, the valley current protection at extremely high duty cycles.

The L6983 device assures an effective overcurrent protection sensing the current flowing in both power elements. In case one of the two current sensing circuitry is ineffective because of the masking time, the device is protected sensing the current on the opposite switch. Thus, the combination of the “peak” and “valley” current limits assure the effectiveness of the overcurrent protection even in extreme duty cycle conditions.

In case the current diverges because of the high-side masking time, the low-side power element is turned on until the switch current level drops below the valley current sense threshold. The low-side operation is able to prevent the high-side turn on, so the device can skip pulses decreasing the switching frequency.

Figure 19. Over current protection behavior

\[
I_{\text{MAX}} = I_{\text{VY}} + \frac{V_{\text{IN}} - V_{\text{OUT}}}{L} \cdot T_{\text{MASK HS}}
\]

(7)

Where \(I_{\text{VY}}\) is the current threshold of the valley sensing circuitry (please refer to Table 6. Electrical characteristics) and \(T_{\text{MASK HS}}\) is the masking time of the high-side switch (75 ns typ.).
In most of the overcurrent conditions, the conduction time of the high-side switch is higher than the masking time and so the peak current protection limits the switch current.

$$I_{MAX} = I_{PK}$$  \hspace{1cm} (8)

The DC current flowing in the load in overcurrent condition is:

$$I_{DCOUT} = I_{MAX} - \frac{1}{2}I_{RIPPLE(V'_{OUT})} = I_{MAX} - \left(\frac{V_{IN} - V_{OUT}}{2 \cdot L} \cdot T_{ON}\right)$$  \hspace{1cm} (9)

The Figure 20. Soft-start procedure with $V_{OUT}$ shorted to GND shows the L6983 soft-start procedure with $V_{OUT}$ shorted to GND.

The Figure 21. Over current procedure with persistent short circuit between $V_{OUT}$ and GND shows the L6983 over current protection with a persistent short circuit between $V_{OUT}$ and GND.
6.9 Thermal shutdown

The shutdown block disables the switching activity if the junction temperature is higher than a fixed internal threshold ($T_{SHDN}$ refer to Table 6. Electrical characteristics). The thermal sensing element is close to the power elements, assuring fast and accurate temperature detection. A hysteresis of approximately 30 °C prevents the device from turning ON and OFF too fast. After a thermal protection event is expired, the L6983 restarts with a new soft-start.

6.10 Power Good

The PGOOD pin indicates whether the output voltage is within its regulation level. The pin output is an open drain MOSFET. The PG is pulled low when:

1. The FB pin voltage is lower than 90% (typ.) of the nominal internal reference for more than 10 µs
2. The FB pin voltage is higher than 120% (typ.) of the nominal internal reference for more than 10 µs (see Section 6.7 Overvoltage protection)
3. During the soft-start procedure also with pre-charged VOUT
4. If a thermal shutdown event occurs
5. If a UVLO event occurs

The PG pin is VIN compatible.
Figure 22. PGOOD thresholds
7 Closing the loop

The following picture shows the typical compensation network required to stabilize the system.

**Figure 23. Block diagram of the loop**

- **PWM control**
- **Current sense**
- **PWM comparator**
- **POW switch**
- **HS switch**
- **LS switch**
- **Compensation network**
- **Error amplifier**
- **Resistor divider**
- **LC filter**
- **VREF**
- **LOAD**
- **VOUT**
- **Vin**
- **RLOAD**
- **L**
- **COUT**
- **Rc**
- **Cc**

### 7.1 GCO(s) control to output transfer function

The accurate control to output transfer function for a buck peak current mode converter can be written as follows:

\[
G_{CO}(s) = \frac{R_{LOAD} \cdot g_{CS}}{1 + \frac{R_{LOAD} \cdot T_{SW}}{L} \cdot \left[ m_{C} \cdot (1 - D) - 0.5 \right]} \cdot \left( 1 + \frac{s}{\omega_{P}} \right) \cdot F_{H}(s) \tag{10}
\]

Where: \( R_{LOAD} \) represents the load resistance, \( g_{CS} \) the equivalent sensing trans-conductance of the current sense circuitry, \( \omega_{P} \) the single pole introduced by the power stage and the \( \omega_{Z} \) zero given by the ESR of the output capacitor. \( F_{H}(s) \) accounts the sampling effect performed by the PWM comparator on the output of the error amplifier that introduces a double pole at one half of the switching frequency.

\[
\omega_{Z} = \frac{1}{ESR \cdot C_{OUT}} \tag{11}
\]

\[
\omega_{P} = \frac{1}{R_{LOAD} \cdot C_{OUT}} + \frac{m_{C} \cdot (1 - D) - 0.5}{L \cdot C_{OUT} \cdot T_{SW}} \tag{12}
\]

where:

\[
\begin{align*}
    m_{C} &= 1 + \frac{S_{e}}{S_{n}} \\
    S_{e} &= ISLOPE \cdot T_{SW} \\
    S_{n} &= \frac{V_{IN} - V_{OUT}}{L}
\end{align*}
\]

Where \( ISLOPE \) is equal to 1 A.

\( S_{n} \) represents the on-time slope of the sensed inductor current, \( S_{e} \) the on-time slope of the external ramp that implements the slope compensation to avoid sub-harmonic oscillations at duty cycle over 50%.

The sampling effect contribution \( F_{H}(s) \) is:
\[ F_H(s) = \frac{1}{1 + \frac{s}{\omega_n \cdot Q_P} + \frac{s^2}{\omega_n^2}} \]  
(14)

where:

\[ Q_P = \frac{1}{\pi \cdot m_C \cdot (1 - D) - 0.5} \]  
(15)

### 7.2 Error amplifier compensation network

The following figure shows the typical compensation network required to stabilize the system.

**Figure 24. Trans-conductance embedded error amplifier**

\[ A_O(s) = \frac{A_{VO} \cdot (1 + s \cdot R_C \cdot C_C)}{s^2 \cdot R_Q \cdot C_O \cdot R_C \cdot C_C + s \cdot (R_Q \cdot C_C + R_Q \cdot C_O + R_C \cdot C_C) + 1} \]  
(16)

where:

\[ A_{VO} = G_m \cdot R_Q \]  
(17)

The poles of this transfer function are (if \( C_C >> C_O \)):

\[ f_{PLF} = \frac{1}{2 \pi \cdot R_Q \cdot C_C} \]  
(18)

\[ f_{PHF} = \frac{1}{2 \pi \cdot R_Q \cdot C_O} \]  
(19)

Whereas the zero is defined as:
\[ f_Z = \frac{1}{2 \cdot \pi \cdot R \cdot C} \quad (20) \]

### 7.3 Voltage divider

The contribution of a simple voltage divider is:

\[ G_{DIV} \left( s \right) = \frac{R_2}{R_1 + R_2} \quad (21) \]

A small signal capacitor in parallel to the upper resistor (only for the adjustable part number) of the voltage divider implements a leading network \( (f_{ZERO} < f_{POLE}) \), sometimes necessary to improve the system phase margin:

**Figure 25. Leading network example**

Laplace transformer of the leading network:

\[ G_{DIV}(s) = \frac{R_2}{R_1 + R_2} \left( \frac{1 + s \cdot R_1 \cdot C_{R1}}{1 + s \cdot \frac{R_1 \cdot R_2}{R_1 + R_2} \cdot C_{R1}} \right) \quad (22) \]

where:

\[ f_Z = \frac{1}{2 \cdot \pi \cdot R \cdot C_{R1}} \quad (23) \]

\[ f_P = \frac{1}{2 \cdot \pi \cdot \frac{R_1 \cdot R_2}{R_1 + R_2} \cdot C_{R1}} \quad (24) \]

\[ f_Z < f_P \quad (25) \]

So closing the loop, the loop gain is:

\[ G(s) = G_{DIV}(s) \cdot G_{CO}(s) \cdot A_O(s) \quad (26) \]
8 Application notes

8.1 Programmable power up threshold

The enable rising threshold is equal to 1.2 V typical (refer to Table 6. Electrical characteristics). The power-up threshold is adjusted according to the following equation:

\[ V_{\text{Power Up}} = 1.2V \cdot \left(1 + \frac{R_{EN \, H}}{R_{EN \, L}}\right) \]  

(27)

Figure 26. Leading network example

The enable falling threshold is equal to 1.0 V typical (refer to Table 6. Electrical characteristics). The turn threshold is obtained according to the following equation:

\[ V_{\text{Power Up}} = 1.0V \cdot \left(1 + \frac{R_{EN \, H}}{R_{EN \, L}}\right) \]  

(28)

8.2 External synchronization (available for low noise mode only)

The device allows a direct connection between a clock source and the EN/CLKIN pin.

Figure 27. External synchronization. Direct connection.

The device internally implements a low-pass filter connected to EN/CLKIN pin that is able to acquire the average value of the applied signal.
The device turns on when the average of the signal applied is higher than $V_{EN}$ rising (refer to Table 6. Electrical characteristics). The device turns off when the average of the signal should be lower than $V_{EN}$ falling (refer to Table 6. Electrical characteristics).

Considering, for example, a clock source with $V_{PP} = 5.0 \text{ V}$, the minimum duty cycle to guarantee the power-up is given by:

$$D_{\text{min}} = \frac{V_{EN}, \text{ Rising}}{V_{PP}} = 0.24$$  \hspace{1cm} (29)

The maximum duty cycle to guarantee the turn-off is given by:

$$D_{\text{MAX}} = \frac{V_{EN}, \text{ Falling}}{V_{PP}} = 0.2$$  \hspace{1cm} (30)

The device allows also the AC coupling.

**Figure 28. External synchronization. AC coupling**

The AC-coupling allows the device to keep the power-up and down thresholds defined by the partition connected to EN/CLKIN pin and described on Section 8.1 Programmable power up threshold.

The following table resumes the minimum pulse duration for the external signal and maximum duty cycle that allows the synchronization by keeping the selected power-up and down thresholds.

**Table 8. External synchronization AC coupling suggested operation range**

<table>
<thead>
<tr>
<th>$V_{PP}$ [V]</th>
<th>TON, MIN, EXT Clock [ns]</th>
<th>DMAX, EXT Clock [%]</th>
</tr>
</thead>
<tbody>
<tr>
<td>2.3</td>
<td>60</td>
<td>45</td>
</tr>
<tr>
<td>3.3</td>
<td>20</td>
<td>30</td>
</tr>
<tr>
<td>5</td>
<td>20</td>
<td>20</td>
</tr>
</tbody>
</table>

The minimum amplitude for the external clock signal is, for both the configurations, equal to 2.3 V.

The network given by $C_{EN}$ and $R_{ENL}$ sets a high-pass filter. Considering a resistor in the order of 220 kΩ, a capacitor equal to 1 nF is a correct choice.

### 8.3 Output voltage adjustment

The error amplifier reference voltage is 0.85 V typical (refer to Table 6. Electrical characteristics). The output voltage is adjustable as per the following equation:

$$V_{OUT} = 0.85V \cdot \left(1 + \frac{R_1}{R_2}\right)$$  \hspace{1cm} (31)
CR1 capacitor is sometimes useful to increase the small signal phase margin (please refer to the Section 7 Closing the loop).

Figure 29. Application circuit

8.4 Switching frequency

A resistor connected to the FSW pin features the selection of the switching frequency (refer to the Table 7. FSW selection).

Connecting the resistor between the pins R_{FSW} and VCC, the internal dithering circuit is turned on. (refer to the Section 6.6 Spread spectrum).

8.5 Design of the power components

8.5.1 Input capacitor selection

The input capacitor voltage rating must be higher than the maximum input operating voltage of the application. During the switching activity a pulsed current flows into the input capacitor and so, its RMS current capability must be selected according to the application conditions. Internal losses of the input filter depends on the ESR value so usually low ESR capacitors (such as multilayer ceramic capacitors) have higher RMS current capability. On the other hand, given the RMS current value, lower ESR input filter has lower losses and so contributes to higher conversion efficiency.

The maximum RMS input current, flowing through the capacitor, can be calculated as follows:

$$I_{RMS} = I_{OUT} \cdot \sqrt{\frac{1 - D}{\eta}} \cdot \frac{D}{\eta}$$

Where $I_{OUT}$ is the maximum DC output current, $D$ is the duty cycles, $\eta$ is the efficiency. This function has a maximum at $D = 0.5$ and, considering $\eta = 1$, it is equal to $I_{OUT}/2$. In a specific application, the range of possible duty cycles has to be considered in order to find out the maximum RMS input current. The maximum and minimum duty cycles can be calculated as:

$$D_{MAX} = \frac{V_{OUT} + \Delta V_{LOWSIDE}}{V_{INMIN} + \Delta V_{LOWSIDE} - \Delta V_{HIGHSIDE}}$$

$$D_{MIN} = \frac{V_{OUT} + \Delta V_{LOWSIDE}}{V_{INMAX} + \Delta V_{LOWSIDE} - \Delta V_{HIGHSIDE}}$$

Where $\Delta V_{HIGHSIDE}$ and $\Delta V_{LOWSIDE}$ are the voltage drops across the embedded switches. The peak-to-peak voltage across the input filter can be calculated as the equation below:

$$V_{PP} = \frac{I_{OUT}}{C_{IN} \cdot F_{SW}} \cdot \left(1 - \frac{D}{\eta} \right) \cdot \frac{D}{\eta} + ESR \cdot (I_{OUT} + \Delta I_{L})$$

In case of negligible ESR (MLCC capacitor), the equation of $C_{IN}$ as a function of the target VPP can be written as follows:
\[ C_{IN} = \frac{I_{OUT}}{V_{PP} \cdot F_{SW}} \left(1 - \frac{D}{\eta}\right) \frac{D}{\eta} \]  
\[ (36) \]

Considering \( \eta = 1 \) this function has its maximum in \( D = 0.5 \):

\[ C_{IN_{\text{min}}} = \frac{I_{OUT}}{4 \cdot V_{PP_{\text{MAX}}} \cdot F_{SW}} \]
\[ (37) \]

Typically, \( C_{IN} \) is dimensioned to keep the maximum peak-peak voltage across the input filter in the order of 5\% \( V_{IN_{\text{MAX}}} \).

In the following table, some suitable capacitor part numbers are listed.

<table>
<thead>
<tr>
<th>Manufacturer</th>
<th>Series</th>
<th>Size</th>
<th>Cap value (µF)</th>
<th>Rated voltage (V)</th>
</tr>
</thead>
<tbody>
<tr>
<td>TDK</td>
<td>CGA5L3X5R1H106K160AB</td>
<td>1206</td>
<td>10</td>
<td>50</td>
</tr>
<tr>
<td></td>
<td>C3216X5R1H106K160AB</td>
<td>1206</td>
<td>10</td>
<td>50</td>
</tr>
<tr>
<td>Murata</td>
<td>GRT31CR61H106KE01</td>
<td>1206</td>
<td>10</td>
<td>50</td>
</tr>
</tbody>
</table>

### 8.5.2 Inductor selection

The inductor current ripple flowing into the output capacitor determines the output voltage ripple. Usually the inductor value is selected in order to keep the current ripple lower than 20\% - 40\% of the output current over the input voltage range. The inductance value can be calculated by the following equation:

\[ \Delta I_L = \frac{V_{IN} - V_{OUT}}{L} \cdot T_{ON} = \frac{V_{OUT}}{L} \cdot T_{OFF} \]  
\[ (38) \]

Where \( T_{ON} \) and \( T_{OFF} \) are the on and off time of the internal power switch. The maximum current ripple, at fixed \( V_{OUT} \), is obtained at maximum \( T_{OFF} \) that is at minimum duty cycle. So fixing \( \Delta I_L = 20\% \) to 40\% of the maximum output current, the minimum inductance value can be calculated:

\[ L_{\text{min}} = \frac{V_{OUT}}{\Delta I_{L_{\text{MAX}}}} \cdot \frac{1 - D_{\text{min}}}{F_{SW}} \]  
\[ (39) \]

For those applications requiring higher inductor value for minimized current ripple, pay attention the maximum value must prevent the sub-harmonic instability given the designed internal slope compensation. As a consequence the inductor value must satisfy the quality factor range:

\[ 0.4 \leq Q_P \leq 1.33 \]  
\[ (40) \]

Where \( Q_P \) has been defined in Section 7.1 GCO(s) control to output transfer function.

The peak current through the inductor is given by:

\[ I_{L,PK} = I_{OUT} + \frac{\Delta I_L}{2} \]  
\[ (41) \]

So if the inductor value decreases, the peak current (that has to be lower than the current limit of the device) increases. The higher is the inductor value, the higher is the average output current that can be delivered, without reaching the current limit.

### 8.5.3 Output capacitor selection

The triangular shape current ripple (with zero average value) flowing into the output capacitor gives the output voltage ripple, that depends on the capacitor value and the equivalent resistive component (ESR). Therefore, the output capacitor has to be selected in order to have a voltage ripple compliant with the application requirements. The voltage ripple equation can be calculated as:

\[ \Delta V_{OUT} = ESR \cdot \Delta I_{L_{\text{MAX}}} + \frac{\Delta I_{L_{\text{MAX}}}}{C_{OUT} \cdot F_{SW}} \]  
\[ (42) \]

For a ceramic (MLCC) capacitor, the capacitive component of the ripple dominates the resistive one. While for an electrolytic capacitor the opposite is true. Neglecting the ESR contribution the minimum value of the output capacitor is given by:
As the compensation network is internal, the output capacitor should be selected in order to have a proper phase margin and then a stable control loop. A good rule to obtain a proper dimensioning for the minimum amount of the output capacitor is set the target system bandwidth equal to $F_{SW}/8$. The following equation keep into account the precedent consideration:

$$C_{OUT, BW, min} = \frac{\Delta I_{L, MAX}}{8 \cdot \Delta V_{OUT} \cdot F_{SW}}$$ \hspace{1cm} (44)

The maximum amount of the output capacitor is given by:

$$C_{OUT, BW, MAX} = \frac{0.960 \cdot 10^{-3}}{V_{OUT}}$$ \hspace{1cm} (45)
The figure below shows the reference evaluation board schematic:

Figure 30. Evaluation board schematic

The additional input filter (C14, L3, C13, L2, C12, and C15) limits the conducted emission on the power supply.
<table>
<thead>
<tr>
<th>Reference</th>
<th>Part number</th>
<th>Description</th>
<th>Manufacturer</th>
</tr>
</thead>
<tbody>
<tr>
<td>C1</td>
<td>CGA5L3X5R1H106K160AB</td>
<td>10 µF 50 V</td>
<td>TDK</td>
</tr>
<tr>
<td>C2A, C2B, C16</td>
<td>CGA4J3X7R1H105K125AB</td>
<td>1 µF 50 V</td>
<td>TDK</td>
</tr>
<tr>
<td>C3-C4</td>
<td>GCM31CR71C106KA64L</td>
<td>10 µF 16 V</td>
<td>MURATA</td>
</tr>
<tr>
<td>C5</td>
<td>CGA6P1X7R1C226M250AC</td>
<td>22 µF 16 V</td>
<td>TDK</td>
</tr>
<tr>
<td>C6</td>
<td>CGA3E2X7R1H104K080AA</td>
<td>100 nF 50 V</td>
<td>TDK</td>
</tr>
<tr>
<td>C7</td>
<td>C2012X8R1C105K125AB</td>
<td>1 µF 16 V</td>
<td>TDK</td>
</tr>
<tr>
<td>C8, C9, C11, C17</td>
<td></td>
<td>NOT MOUNTED</td>
<td></td>
</tr>
<tr>
<td>C12-C13-C14</td>
<td>GRM31CR71H475KA12L</td>
<td>4.7 µF 50 V</td>
<td>Murata</td>
</tr>
<tr>
<td>C15</td>
<td>EEHZA1H101P</td>
<td>100 µF, 50 V</td>
<td>Panasonic</td>
</tr>
<tr>
<td>L1B</td>
<td></td>
<td>NOT MOUNTED</td>
<td></td>
</tr>
<tr>
<td>L1A</td>
<td>XAL6060-472ME</td>
<td>4.7 µH</td>
<td>Coilcraft</td>
</tr>
<tr>
<td>L2</td>
<td>XAL4030-472ME</td>
<td>4.7 µH</td>
<td>Coilcraft</td>
</tr>
<tr>
<td>L3</td>
<td>MPZ2012S221A</td>
<td>220 Ω 100 MHz</td>
<td>TDK</td>
</tr>
<tr>
<td>R1</td>
<td></td>
<td>10 k 1%</td>
<td>any</td>
</tr>
<tr>
<td>R2</td>
<td></td>
<td>NOT MOUNTED</td>
<td></td>
</tr>
<tr>
<td>R3</td>
<td></td>
<td>400 k 1%</td>
<td>any</td>
</tr>
<tr>
<td>R4</td>
<td></td>
<td>82 k 1%</td>
<td>any</td>
</tr>
<tr>
<td>R5</td>
<td></td>
<td>0</td>
<td>any</td>
</tr>
<tr>
<td>R6</td>
<td></td>
<td>NOT MOUNTED</td>
<td></td>
</tr>
<tr>
<td>R7</td>
<td></td>
<td>1 M 1%</td>
<td>any</td>
</tr>
<tr>
<td>R8</td>
<td></td>
<td>10 k 1%</td>
<td>any</td>
</tr>
<tr>
<td>R9</td>
<td></td>
<td>NOT MOUNTED</td>
<td></td>
</tr>
<tr>
<td>R11</td>
<td></td>
<td>NOT MOUNTED</td>
<td></td>
</tr>
<tr>
<td>R12</td>
<td></td>
<td>0</td>
<td>any</td>
</tr>
<tr>
<td>R13</td>
<td></td>
<td>0.1 k 1%</td>
<td>any</td>
</tr>
<tr>
<td>J2</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>U1</td>
<td>L6983CQTR</td>
<td></td>
<td>ST Microelectronics</td>
</tr>
</tbody>
</table>
Figure 31. Top layer

Figure 32. Bottom layer
The following three figures show the efficiency and power losses acquired on the standard evaluation board of the device, STEVAL-ISA208V1, selecting the following output filter:

- **C\text{\textsubscript{OUT}}:**
  - 1 x CGA6P1X7R1C226M250AC 22 µF 16 V (TDK);
  - 2 x CGA5L3X5R1H106K160AB 10 µF 50 V (TDK).
- **Inductor:**
  - XAL6060-153ME (Coilcraft)

**Figure 33. Efficiency \(V_{\text{IN}} = 24\text{ V}; V_{\text{OUT}} = 5\text{ V}; F_{\text{SW}} = 0.4\text{ MHz}\)**

**Figure 34. Efficiency \(V_{\text{IN}} = 24\text{ V}; V_{\text{OUT}} = 5\text{ V}; F_{\text{SW}} = 0.4\text{ MHz}\) (log scale)**
The following three figures show the efficiency and power losses acquired on the standard evaluation board of the device, STEVAL-ISA208V1, selecting the following output filter:

- **C<sub>OUT</sub>:**
  - 1 x CGA6P1X7R1C226M250AC 22 µF 16 V (TDK);
  - 2 x CGA5L3X5R1H106K160AB 10 µF 50 V (TDK).

- **Inductor:**
  - XAL6060-153ME (Coilcraft).

**Figure 35. Power losses V<sub>IN</sub> = 24 V; V<sub>OUT</sub> = 5 V; F<sub>SW</sub> = 0.4 MHz**

**Figure 36. Efficiency V<sub>IN</sub> = 12 V; V<sub>OUT</sub> = 5 V; F<sub>SW</sub> = 0.4 MHz**
The following three figures show the efficiency and power losses acquired on the standard evaluation board of the device, STEVAL-ISA208V1, selecting the following output filter:

- **C\text{OUT}**:  
  - 2 x CGA6P1X7R1C226M250AC 22 µF 16 V (TDK);  
  - 2 x CGA5L3X5R1H106K160AB 10 µF 50 V (TDK).
- **Inductor**:  
  - XAL6060-822ME (Coilcraft).
Figure 39. Efficiency $V_{IN} = 24\text{ V}; \ V_{OUT} = 3.3\text{ V}; \ F_{SW} = 0.4\text{ MHZ}$

$V_{IN} = 24\text{ V}; \ V_{OUT} = 3.3\text{ V}; \ F_{SW} = 0.4\text{ MHz}$

Figure 40. Efficiency $V_{IN} = 24\text{ V}; \ V_{OUT} = 3.3\text{ V}; \ F_{SW} = 0.4\text{ MHZ}$ (log scale)

$V_{IN} = 24\text{ V}; \ V_{OUT} = 3.3\text{ V}; \ F_{SW} = 0.4\text{ MHz}$
The following three figures show the efficiency and power losses acquired on the standard evaluation board of the device, STEVAL-ISA208V1, selecting the following output filter:

- **C<sub>OUT</sub>:**
  - 2 x CGA6P1X7R1C226M250AC 22 µF 16 V (TDK);
  - 2 x CGA5L3X5R1H106K160AB 10 µF 50 V (TDK).

- **Inductor:**
  - XAL6060-822ME (Coilcraft)
Figure 42. Efficiency $V_{IN} = 12 \text{ V}; V_{OUT} = 3.3 \text{ V}; F_{SW} = 0.4 \text{ MHz}$

$V_{IN} = 12 \text{ V}; V_{OUT} = 3.3 \text{ V}; F_{SW} = 0.4 \text{ MHz}$

![Efficiency curve for $V_{IN} = 12 \text{ V}; V_{OUT} = 3.3 \text{ V}; F_{SW} = 0.4 \text{ MHz}$](image)

Figure 43. Efficiency $V_{IN} = 12 \text{ V}; V_{OUT} = 3.3 \text{ V}; F_{SW} = 0.4 \text{ MHz}$ (log scale)

$V_{IN} = 12 \text{ V}; V_{OUT} = 3.3 \text{ V}; F_{SW} = 0.4 \text{ MHz}$

![Efficiency curve for $V_{IN} = 12 \text{ V}; V_{OUT} = 3.3 \text{ V}; F_{SW} = 0.4 \text{ MHz}$ (log scale)](image)
The following three figures show the efficiency and power losses acquired on the standard evaluation board of the device, STEVAL-ISA208V1, selecting the following output filter:

- **C\text{\textit{\text{o}}ut}**:  
  - 1 x CGA6P1X7R1C226M250AC 22 µF 16 V (TDK);  
  - 1 x CGA5L3X5R1H106K160AB 10 µF 50 V (TDK).

- **Inductor**:  
  - XAL6060-472ME (Coilcraft).
Figure 45. Efficiency $V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHZ}$

$V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHz}$

Figure 46. Efficiency $V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHZ}$ (log scale)

$V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHz}$
Figure 47. Power losses $V_{IN} = 24$ V; $V_{OUT} = 3.3$ V; $F_{SW} = 1.0$ MHz

The following three figures show the efficiency and power losses acquired on the standard evaluation board of the device, STEVAL-ISA208V1, selecting the following output filter:

- **C$^{OUT}$:**
  - 1 x CGA6P1X7R1C226M250AC 22 µF 16 V (TDK);
  - 1 x CGA5L3X5R1H106K160AB 10 µF 50 V (TDK).
- **Inductor:**
  - XAL6060-472ME (Coilcraft).
Figure 48. Efficiency $V_{IN} = 12 \, V$; $V_{OUT} = 3.3 \, V$; $F_{SW} = 1.0 \, MHZ$

$V_{IN} = 12 \, V$; $V_{OUT} = 3.3 \, V$; $F_{SW} = 1.0 \, MHZ$

Figure 49. Efficiency $V_{IN} = 12 \, V$; $V_{OUT} = 3.3 \, V$; $F_{SW} = 1.0 \, MHZ$ (log scale)
The following three figures show the efficiency and power losses acquired on the standard evaluation board of the device, STEVAL-ISA208V1, selecting the following output filter:

- **C\text{Out}**:  
  - 1 x CGA6P1X7R1C226M250AC 22 µF 16V (TDK);  
  - 2 x CGA5L3X5R1H106K160AB 10 µF 50V (TDK).
- **Inductor**:  
  - XAL6060-472ME (Coilcraft).
Figure 51. Efficiency $V_{IN} = 24 \, V; \, V_{OUT} = 5 \, V; \, F_{SW} = 1.0 \, MHz$

Figure 52. Efficiency $V_{IN} = 24 \, V; \, V_{OUT} = 5.0 \, V; \, F_{SW} = 1.0 \, MHz$ (log scale)

Figure 53. Power losses $V_{IN} = 24 \, V; \, V_{OUT} = 5.0 \, V; \, F_{SW} = 1.0 \, MHz$
The following three figures show the efficiency and power losses acquired on the standard evaluation board of the device, STEVAL-ISA208V1, selecting the following output filter:

- **C_{OUT}**:  
  - 1 x CGA6P1X7R1C226M250AC 22 µF 16 V (TDK);  
  - 1 x CGA5L3X5R1H106K160AB 10 µF 50 V (TDK).
- **Inductor**:  
  - XAL6060-472ME (Coilcraft).

Figure 54. Efficiency $V_{IN} = 12 \text{ V}; V_{OUT} = 5.0 \text{ V}; F_{SW} = 1.0 \text{ MHz}$
Figure 55. Efficiency $V_{IN} = 12\,V$; $V_{OUT} = 5.0\,V$; $F_{SW} = 1.0\,MHZ$ (log scale)

\begin{figure}
\centering
\begin{tikzpicture}
\begin{axis}[
width=\textwidth,
height=0.4\textwidth,
axis lines=left,
axis line style={thick},
xlabel={$I_{OUT}$ [A]},
ylabel={Efficiency [%]},
xtick={0,0.01,0.1,1},
ytick={0,10,20,30,40,50,60,70,80,90,100},
log basis y={10},
]
\addplot[thick, blue, mark=*, marker options={scale=1.5, fill=white}]
coordinates {
(0.001,100)
(0.01,90)
(0.1,80)
(1,70)
};
\addlegendentry{LCM}
\addplot[thick, red, mark=x, marker options={scale=1.5, fill=white}]
coordinates {
(0.001,100)
(0.01,90)
(0.1,80)
(1,70)
};
\addlegendentry{LNM}
\end{axis}
\end{tikzpicture}
\end{figure}

Figure 56. Power losses $V_{IN} = 12\,V$; $V_{OUT} = 5.0\,V$; $F_{SW} = 1.0\,MHZ$

\begin{figure}
\centering
\begin{tikzpicture}
\begin{axis}[
width=\textwidth,
height=0.4\textwidth,
axis lines=left,
axis line style={thick},
xlabel={$I_{OUT}$ [A]},
ylabel={Power losses [W]},
xtick={0,0.5,1,1.5,2,2.5,3},
ytick={0,0.5,1,1.5,2,2.5,3,4,5,6,7,8,9,10,11,12,13,14,15,16},
]
\addplot[thick, blue, mark=*, marker options={scale=1.5, fill=white}]
coordinates {
(0,0)
(0.5,0.5)
(1,1)
(1.5,1.5)
(2,2)
(2.5,2.5)
};
\addlegendentry{LCM}
\addplot[thick, red, mark=x, marker options={scale=1.5, fill=white}]
coordinates {
(0,0)
(0.5,0.5)
(1,1)
(1.5,1.5)
(2,2)
(2.5,2.5)
};
\addlegendentry{LNM}
\addplot[thick, black, mark=square, marker options={scale=1.5, fill=white}]
coordinates {
(0,0)
(0.5,0.5)
(1,1)
(1.5,1.5)
(2,2)
(2.5,2.5)
};
\addlegendentry{POUT}
\end{axis}
\end{tikzpicture}
\end{figure}
The thermal design is important in order to prevent thermal shutdown of the device if junction temperature goes above 165 °C. The three different sources of losses within the device are:

1. Conduction losses due to the on-resistance of high-side switch (R\textsubscript{DS\_ON\_HS}) and low-side switch (R\textsubscript{DS\_ON\_LS}); these are equal to:

\[ P_{COND} = R_{DS\_ON\_HS} \cdot I_{OUT}^2 \cdot D + R_{DS\_ON\_LS} \cdot I_{OUT}^2 \cdot (1 - D) \]  

(46)

where D is the duty cycle of the selected application and is given by the following formula:

\[ D = \frac{V_{OUT} + (R_{DS\_ON\_LS} + DCRI) \cdot I_{OUT}}{V_{IN} - (R_{DS\_ON\_HS} - R_{DS\_ON\_LS}) \cdot I_{OUT}} \]  

(47)

In order to obtain a more accurate estimation it is necessary to keep into account that the amount of resistance of the internal power MOSFET increases together with the temperature. For this reason, the value of R\textsubscript{DS\_ON\_HS} and R\textsubscript{DS\_ON\_LS} should be increased from the typical of a factor equal to 15%.

1. Switching losses due to high-side power MOSFET turn-ON and OFF; these can be calculated as per below:

\[ P_{SW} = V_{IN} \cdot I_{OUT} \cdot \frac{T_{RISE} + T_{FALL}}{2} = V_{IN} \cdot I_{OUT} \cdot T_{SW} \cdot F_{SW} \]  

(48)

where \( T_{RISE} \) and \( T_{FALL} \) are the overlap times of the voltage across the high side power switch (VDS) and the current flowing into it during turn-ON and turn-OFF phases, as shown in Figure 57. Switching losses. \( T_{SW} \) is the equivalent switching time. For this device the typical value for the equivalent switching time is 20 ns.

1. Quiescent current losses, calculated as the equation below:

\[ P_{Q} = V_{IN} \cdot I_{Q, MAX} \]  

(49)

where \( I_{Q} \) is the quiescent current and depends on the \( V_{BIAS} \) connections. If \( V_{BIAS} \) is connected to GND, the maximum is equal to 3 mA. Otherwise if \( V_{BIAS} \) is connected to \( V_{OUT} \) the quiescent current is given by:

\[ I_{Q, MAX} = 0.8 \text{mA} + \frac{1}{\text{L6983}} \cdot \frac{V_{BIAS}}{V_{IN}} \cdot 2.3 \text{mA} \]  

(50)

The power losses are given by:

\[ P_{LOSS} = P_{COND} + P_{SW} + P_{Q} \]  

(51)

The junction temperature \( T_{J} \) can be calculated as:

\[ T_{J} = T_{A} + R_{th\_JA} \cdot P_{LOSS} \]  

(52)

where \( T_{A} \) is the ambient temperature. \( R_{th\_JA} \) is the equivalent thermal resistance junction to ambient of the device; it can be calculated as the parallel of many paths of heat conduction from the junctions to the ambient. For this device the path through the exposed pad is the one conducting the largest amount of heat. The \( R_{th\_JA} \) measured on the demonstration board described in the following section is about 30 °C/W.
It is also possible to estimate the junction temperature directly from the efficiency measures acquired on a stationary application condition.

Considering that the power losses are given by:

$$P_{LOSS} = P_{IN} - P_{OUT}$$  \hspace{1cm} (53)$$

Neglecting the AC losses of the selected inductor, the power losses related to the L6983 are given by:

$$P_{LOSS\_L6983} = V_{IN} \cdot I_{IN} - V_{OUT} \cdot I_{OUT} - DCR \cdot I_{OUT}^2$$  \hspace{1cm} (54)$$

Therefore, the junction temperature $T_J$ can be calculated as:

$$T_J = T_A + R_{thJA} \cdot P_{LOSS\_L6983}$$  \hspace{1cm} (55)$$
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.
12.1 QFN16 (3x3 mm) package information

Figure 58. QFN16 (3x3 mm) package outline
Table 11. QFN16 (3x3 mm) mechanical data

<table>
<thead>
<tr>
<th>Dim.</th>
<th>mm</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
</tr>
</thead>
<tbody>
<tr>
<td>A</td>
<td></td>
<td>0.7</td>
<td>0.75</td>
<td>0.8</td>
</tr>
<tr>
<td>A1</td>
<td></td>
<td>0</td>
<td>0.02</td>
<td>0.05</td>
</tr>
<tr>
<td>A3</td>
<td></td>
<td>0.203 Ref.</td>
<td>0.02</td>
<td>0.05</td>
</tr>
<tr>
<td>b</td>
<td></td>
<td>0.18</td>
<td>0.25</td>
<td>0.3</td>
</tr>
<tr>
<td>D</td>
<td></td>
<td>3.00 BSC</td>
<td></td>
<td></td>
</tr>
<tr>
<td>E</td>
<td></td>
<td>3.00 BSC</td>
<td></td>
<td></td>
</tr>
<tr>
<td>e</td>
<td></td>
<td>0.50 BSC</td>
<td></td>
<td></td>
</tr>
<tr>
<td>D2</td>
<td></td>
<td>0.43</td>
<td>0.48</td>
<td>0.53</td>
</tr>
<tr>
<td>E2</td>
<td></td>
<td>0.81</td>
<td>0.86</td>
<td>0.91</td>
</tr>
<tr>
<td>L</td>
<td></td>
<td>0.35</td>
<td>0.4</td>
<td>0.45</td>
</tr>
<tr>
<td>K</td>
<td></td>
<td>0.84</td>
<td></td>
<td></td>
</tr>
<tr>
<td>K1</td>
<td></td>
<td>0.5</td>
<td></td>
<td></td>
</tr>
<tr>
<td>K2</td>
<td></td>
<td>0.86</td>
<td></td>
<td></td>
</tr>
<tr>
<td>N</td>
<td></td>
<td>16</td>
<td></td>
<td></td>
</tr>
<tr>
<td>ND</td>
<td></td>
<td>4</td>
<td></td>
<td></td>
</tr>
<tr>
<td>NE</td>
<td></td>
<td>4</td>
<td></td>
<td></td>
</tr>
<tr>
<td>aaa</td>
<td></td>
<td>0.05</td>
<td></td>
<td></td>
</tr>
<tr>
<td>bbb</td>
<td></td>
<td>0.1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>ccc</td>
<td></td>
<td>0.05</td>
<td></td>
<td></td>
</tr>
<tr>
<td>ddd</td>
<td></td>
<td>0.05</td>
<td></td>
<td></td>
</tr>
<tr>
<td>eee</td>
<td></td>
<td>0.05</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

Figure 59. QFN16 (3x3 mm) recommended footprint
## Table 12. Order codes

<table>
<thead>
<tr>
<th>Part numbers</th>
<th>Output voltage</th>
<th>Light load behavior</th>
<th>Package</th>
<th>Packaging</th>
</tr>
</thead>
<tbody>
<tr>
<td>L6983CQTR</td>
<td>Adj.</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>L6983C50QTR</td>
<td>5 V</td>
<td>LCM (Low Consumption Mode)</td>
<td></td>
<td>QFN16 Tape and reel</td>
</tr>
<tr>
<td>L6983C33QTR</td>
<td>3.3 V</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>L6983NQTR</td>
<td>Adj.</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>L6983N50QTR</td>
<td>5 V</td>
<td>LNM (Low Noise Mode)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>L6983N33QTR</td>
<td>3.3 V</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>
## Revision history

**Table 13. Document revision history**

<table>
<thead>
<tr>
<th>Date</th>
<th>Revision</th>
<th>Changes</th>
</tr>
</thead>
<tbody>
<tr>
<td>29-Oct-2019</td>
<td>1</td>
<td>Initial release.</td>
</tr>
<tr>
<td>20-Apr-2020</td>
<td>2</td>
<td>Updated: Feature on the cover page, $R_{DS(ON, LS)}$ value in Table 6. Electrical characteristics, Section 8.5.2 Inductor selection, Figure 30. Evaluation board schematic and Table 10. Bill of material.</td>
</tr>
</tbody>
</table>
# Contents

1. **Diagram** .................................................. 3
2. **Pin configuration** ........................................... 4
3. **Typical application circuit** .............................. 6
4. **Absolute maximum ratings** ............................ 7
   4.1 ESD protection ........................................ 7
   4.2 Thermal characteristics ............................. 7
5. **Electrical characteristics** .............................. 8
   5.1 Frequency selection table .......................... 10
6. **Functional description** ................................. 11
   6.1 Enable .................................................. 11
   6.2 Soft-start .............................................. 12
   6.3 Undervoltage lockout .............................. 13
   6.4 Light-load operation ................................ 14
      6.4.1 Low consumption mode (LCM) ............. 14
      6.4.2 Low noise mode (LNM) ..................... 18
      6.4.3 Efficiency for low consumption mode and low noise mode part number .... 19
      6.4.4 Load regulation for low consumption mode and Low noise mode part number 20
   6.5 Switch-over feature ................................ 21
   6.6 Spread spectrum .................................... 21
   6.7 Overvoltage protection ............................ 21
   6.8 Overcurrent protection ............................ 22
   6.9 Thermal shutdown .................................. 24
   6.10 Power Good ......................................... 24
7. **Closing the loop** ....................................... 26
   7.1 GCO(s) control to output transfer function  .... 26
   7.2 Error amplifier compensation network ......... 27
   7.3 Voltage divider ...................................... 28
8. **Application notes** ....................................... 29
   8.1 Programmable power up threshold ............... 29
List of tables

Table 1. Pin description ......................................................................................................................... 4
Table 2. Typical application component .................................................................................................. 6
Table 3. Absolute maximum ratings ........................................................................................................ 7
Table 4. ESD performance ....................................................................................................................... 7
Table 5. Thermal data ............................................................................................................................... 7
Table 6. Electrical characteristics ........................................................................................................... 8
Table 7. FSW selection ............................................................................................................................ 10
Table 8. External synchronization AC coupling suggested operation range ............................................. 30
Table 9. Capacitor part numbers ............................................................................................................. 32
Table 10. Bill of material ......................................................................................................................... 35
Table 11. QFN16 (3x3 mm) mechanical data .......................................................................................... 55
Table 12. Order codes ............................................................................................................................ 56
Table 13. Document revision history ...................................................................................................... 57
List of figures

Figure 1. Block diagram .......................................................... 3
Figure 2. Pin connection (top through view) ............................. 4
Figure 3. Basic application (adjustable version) ......................... 6
Figure 4. Power-up/down behavior .......................................... 12
Figure 5. Soft-start procedure ................................................. 13
Figure 6. Soft-start phase with \( I_{\text{OUT}} = 2.5 \, \text{A} \) ......................... 13
Figure 7. Light load operation .................................................... 14
Figure 8. LCM operation with \( I_{\text{SKIP}} = 600 \, \text{mA} \) typ. at zero load. \( L = 15 \, \mu\text{H}; C_{\text{OUT}} = 40 \, \mu\text{F} \)........... 15
Figure 9. LCM operation over loading condition (part 1-pulse skipping) ................................................... 15
Figure 10. LCM operation over loading condition (part 2-pulse skipping) ......................................................... 16
Figure 11. LCM operation over loading condition (part 3-pulse skipping) ............................................................... 16
Figure 12. LCM operation over loading condition (part 4-CCM) .............................................................................. 17
Figure 13. Low noise mode operation at zero load ..................... 18
Figure 14. Light-load efficiency for low consumption mode and low noise mode - linear scale ........................................ 19
Figure 15. Light-load efficiency for low consumption mode and low noise mode - log scale .............................................. 19
Figure 16. Load regulation for LCM and LNLM. \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 5 \, \text{V}; F_{\text{SW}} = 400 \, \text{kHz} \) - linear scale .................. 20
Figure 17. Load regulation for low noise mode. \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 5 \, \text{V}; F_{\text{SW}} = 400 \, \text{kHz} \) - log scale .................. 20
Figure 18. Switch-over ............................................................. 21
Figure 19. Over current protection behavior ............................. 22
Figure 20. Soft-start procedure with \( V_{\text{OUT}} \) shorted to GND .............................................................................. 23
Figure 21. Over current procedure with persistent short circuit between \( V_{\text{OUT}} \) and GND ......................................................... 24
Figure 22. PGGOOD thresholds ................................................... 25
Figure 23. Block diagram of the loop ........................................... 26
Figure 24. Trans-conductance embedded error amplifier ............. 27
Figure 25. Leading network example .......................................... 28
Figure 26. Leading network example .......................................... 29
Figure 27. External synchronization. Direct connection ............... 29
Figure 28. External synchronization. AC coupling ..................... 30
Figure 29. Application circuit ..................................................... 31
Figure 30. Evaluation board schematic ........................................ 34
Figure 31. Top layer ................................................................. 36
Figure 32. Bottom layer ............................................................ 36
Figure 33. Efficiency \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 5 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) ............................................. 37
Figure 34. Efficiency \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 5 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) (log scale) ................................................... 37
Figure 35. Power losses \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 5 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) ............................................. 38
Figure 36. Efficiency \( V_{\text{IN}} = 12 \, \text{V}; V_{\text{OUT}} = 5 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) ............................................. 38
Figure 37. Efficiency \( V_{\text{IN}} = 12 \, \text{V}; V_{\text{OUT}} = 5 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) (log scale) ................................................... 39
Figure 38. Power losses \( V_{\text{IN}} = 12 \, \text{V}; V_{\text{OUT}} = 5 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) ............................................. 39
Figure 39. Efficiency \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) ............................................. 40
Figure 40. Efficiency \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) (log scale) ................................................... 40
Figure 41. Power losses \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) ............................................. 41
Figure 42. Efficiency \( V_{\text{IN}} = 12 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) ............................................. 42
Figure 43. Efficiency \( V_{\text{IN}} = 12 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) (log scale) ................................................... 42
Figure 44. Power losses \( V_{\text{IN}} = 12 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 0.4 \, \text{MHZ} \) ............................................. 43
Figure 45. Efficiency \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHZ} \) ............................................. 44
Figure 46. Efficiency \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHZ} \) (log scale) ................................................... 44
Figure 47. Power losses \( V_{\text{IN}} = 24 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHZ} \) ............................................. 45
Figure 48. Efficiency \( V_{\text{IN}} = 12 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHZ} \) ............................................. 46
Figure 49. Efficiency \( V_{\text{IN}} = 12 \, \text{V}; V_{\text{OUT}} = 3.3 \, \text{V}; F_{\text{SW}} = 1.0 \, \text{MHZ} \) (log scale) ................................................... 46
Figure 50. Power losses $V_{IN} = 12$ V; $V_{OUT} = 3.3$ V; $F_{SW} = 1.0$ MHz ...................................... 47
Figure 51. Efficiency $V_{IN} = 24$ V; $V_{OUT} = 5$ V; $F_{SW} = 1.0$ MHz ........................................... 48
Figure 52. Efficiency $V_{IN} = 24$ V; $V_{OUT} = 5.0$ V; $F_{SW} = 1.0$ MHz (log scale) ................................ 48
Figure 53. Power losses $V_{IN} = 24$ V; $V_{OUT} = 5.0$ V; $F_{SW} = 1.0$ MHz ..................................... 48
Figure 54. Efficiency $V_{IN} = 12$ V; $V_{OUT} = 5.0$ V; $F_{SW} = 1.0$ MHz ........................................ 49
Figure 55. Efficiency $V_{IN} = 12$ V; $V_{OUT} = 5.0$ V; $F_{SW} = 1.0$ MHz (log scale) ......................... 50
Figure 56. Power losses $V_{IN} = 12$ V; $V_{OUT} = 5.0$ V; $F_{SW} = 1.0$ MHz ..................................... 50
Figure 57. Switching losses .............................................................. 52
Figure 58. QFN16 (3x3 mm) package outline ............................................. 54
Figure 59. QFN16 (3x3 mm) recommended footprint .................................. 55